Chip tantalum capacitors (Fail-safe open structure type) TCFG Series B Case

Features

- 1) Safety design by open function built in.
- 2) Wide capacitance range
- 3) Screening by thermal shock.



Case code	L	W1	W2	Н	S
B 3528-21(1411)	3.5±0.2	2.8±0.2	1.9±0.2	1.9±0.2	0.8±0.3



Capacitance range

TCFG series B Case

	Rated voltage (V)						
(μF)	2.5 0E	4 0G	6.3 0J	10 1A	16 1C	20 1D	25 1E
3.3 (335)					В	В	В
4.7 (475)				В	В	B * 🛛	<i>lew</i> /B
6.8 (685)				В	В	B *	
10 (106)			В	В	В	B *	
15 (156)		В	В	В	В		
22 (226)		В	В	В	В		
33 (336)		В	В	В			
47 (476)		В	В	В			
68 (686)		В	вИ	<i>lew</i> /B			
100 (107)		В	ви	<i>lew</i> /B			
150 (157)		в	Vew B	B *			
220 (227)	В	в	<i>Vew</i> /B				

Remark) Case size codes (B) in the above show each size products line-up.

*: Under development

New product

Marking

The indications listed below should be given on the surface of a capacitor.

- ① Polarity : The polarity should be shown by \Box bar. (on the anode side)
- 2 Rated DC voltage : Due to the small size of A case, a voltage code is used as shown below.

③ Nominal capacitance

[B Case]

note 1) Visual typical example (1) voltage code (2) capacitance code



note 2) voltage code and capacitance code are variable with parts number

TCFG Series B Case

 Characteristics 	
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Item	Item Performance				Test conditions (based on JIS C5101-1 and JIS C5101-3)											
Operating Tem	perature	-5	5 °C	to +	125	5 °C					Vo	Voltage reduction when temperature exceeds +85°C				eds +85°C
Maximum operatir with no voltage de	ng temperature rating	+8	5 °C													
Rated Voltage	(V.DC)	2.5	2.5 4 6.3 10 16 20 25				at	at 85°C								
Category Volta	ge (V.DC)	1.6	1.6 2.5 4 6.3 10 13 16				at	at 125°C								
Surge Voltage		3.2	5.0	8	1:	3 20	26	6	32		at	85°C				
DC leakage cu	rrent	0.5 (SI	5μA α howr	or 0.0	010 Sta	V wl ndar	nich d lis	eve t")	er is	greater	As As Vo	per 4. per 4. Itage :	9 JIS C 51 5.1 JIS C Rated vol	01-1 5101 tage	l -3 for 1 min	
Capacitance to	lerance	Sh ±1	all be 0%, :	e sati ±20%	sfie 6	ed allo	owar	nce	ran	ge.	As As Me Me Me	per 4. per 4. asuring asuring asuring	7 JIS C 51 5.2 JIS C frequency voltage circuit	01-1 5101 : 12 : 0. : D	l -3 20±12Hz 5Vrms, +1.5V.l C Equivalent se	DC eries circuit
Tangent of loss (Df, tanδ)	angent of loss angle St Df, tanð)			e sati	sfie	d the	volt	age	e or	"Standard list"	As As Me Me Me	per 4. per 4. asuring asuring asuring	8 JIS C 51 5.3 JIS C 5 frequency voltage circuit	01-1 5101 : 12 : 0. : D	l -3 20±12Hz 5Vrms, +1.5V.l C Equivalent se	DC eries circuit
Impedance		Shall be satisfied the voltage on "Standard list"						As per 4.10 JIS C 5101-1 As per 4.5.4 JIS C 5101-3 Measuring frequency : 100±10kHz Measuring voltage : 0.5Vrms or less Measuring circuit : DC Equivalent series circu			ries circuit					
Resistance to soldering heat	Appearance	Th Th	There should be no significant abnormality. The indications should be clear.					As As	As per 4.14 JIS C 5101-1 As per 4.6 JIS C 5101-3							
-	L.C	TC TC Otl	FGB FGB hers	1E4 0G2	75 27	Less Less Less	s tha s tha s tha	in 1 an 1 an ii	50% 50% nitia	6 of initial limit 6 of initial limit I limit	Dip in the solder bath Solder temp : 260±5°C Duration : 5±0.5s Repetition : 1 After the specimens, leave it at room temperatu for over 24h and then measure the sample.					
	ΔC / C	TC TC Otl	FGB FGB hers	1E4 0G2	75 27	±10 ±15 ±5%	% %							mperature ple.		
	tanδ	3.3 47 TC	3 to 3 to 22 FGB	3μF 20μF 0E22	: L : L 27	ess tł ess tł Less	ian i ian i tha	initi 150 in 2	al lir)% (200%	nit of initial limit 6 of initial limit		-				
Fail-Safe open	unit actuation	Wi	thin 3	320°	C -	20s					Dip	o in the Solde	e solder ba r temp : 32	th 20±5	°C	
Temperature cycle	Appearance	Th	ere s	houl	d b	e no s	signi	ifica	ant a	bnormality.	As As	per 4. per 4.	16 JIS C 5 10 JIS C 5	101- 101-	-1 -3	
	L.C	TC TC Of	FGB FGB	1E4 0G2	75 27	Less Less	s tha s tha	in 1 an 1 an ii	50% 50%	6 of initial limit 6 of initial limit 1 limit	Re wit	petition hout d	n : 5 cycle iscontinua	s (1 tion.	cycle : steps 1	to 4)
									1 III.	-	Step	Temp). °C	Time	-	
	AC / C	TC	FGB	0G2	27	With	in ±	159	%			2	-oo±3 Room te	mn	30±3min 3min_or less	-
		Ot	hers			: With	in ±	10	%			3	125±2	°C	30±3min	-
	tanδ	3.3	3 to 3	3μF	÷L	ess th	ian i	initi	al lir	nit st initial limit		4	Room te	mp.	3min. or less	
		TC	FGB	1C3	.∟ 36	Less	tha	in 1	50%	6 of initial limit	Aft for	After the specimens, leave it at room temperatur for over 24h and then measure the sample.			mperature ple.	
Moisture resistance	Appearance	Th Th	ere s e ind	houl	d b ons	e no : shou	signi Id be	fica e cl	ant a ear.	bnormality.	As As	per 4. per 4.	22 JIS C 5 12 JIS C 5	101- 101-	-1 -3	
	L.C	TC TC Ot	FGB FGB hers	1E4 0G2	75 27	Less Less Less	s tha s tha s tha	in 1 an 1 an ii	50% 50% nitia	6 of initial limit 6 of initial limit 1 limit	Aft coi 60	er leav ndition ±2°C a	that the sa that the te down of the te	mple empe 5%F	e under such a erature and hu RH, respective	tmospheric midity are y, for
	ΔC / C	TC Otl	CFGB hers	0G2	27	: With : With	iin ± iin ±	15º 10º	%		an	d then	measure	the s	ample.	or over 24h
	3.3 to 33μ F : Less than initial limit 47 to 100μ F : Less than 150% of initial limit TCFGB1C336 : Less than 150% of initial limit															



Item		Performance	Test conditions (based on JIS C5101-1 and JIS C5101-3)				
Temperature	Temp.	_55°C	As per 4.29 JIS C 5101-1 As per 4.13 JIS C 5101-3				
Stability	ΔC / C	Within 0/–12%of initial value TCFGB0G227 : Within 0/–15%of initial value	As per 4.13 JIS C 5101-3				
	tanδ	Shall be satisfied the voltage on "Standard list"					
	L.C	-					
	Temp.	+85°C					
	ΔC / C	Within +10/0%of initial value TCFGB0G227 : Within +12/0%of initial value					
	tanδ	Shall be satisfied the voltage on "Standard list"					
	L.C	5µA or 0.1CV whichever is greater TCFGB0G227 : 5µA or 0.2CV whichever is greater	_				
	Temp.	+125°C	_				
	ΔC / C	Within +15/0%of initial value	_				
	tanδ	Shall be satisfied the voltage on "Standard list"					
	L.C	6.3μA or 0.125CV whichever is greater TCFGB1E475 : 0.2CV TCFGB0G227 : 0.25CV					
Surge	Appearance	There should be no significant abnormality.	As per 4.26 JIS C 5101-1				
voitage	L.C	TCFGB1E475 : Less than 150% of initial limit TCFGB0G227 : Less than 150% of initial limit Others : Less than initial limit	As per 4.14 JIS C 5101-3 Apply the specified surge voltage every 5 ± 0.5 min. for 30 ± 5 seach time in the atmospheric condition of $85\pm 2^{\circ}$ C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature for over 24h and then measure the sample.				
	ΔC / C	TCFGB0G227 : Less than ±15% TCFGB0E227 : Less than ±12% Others : Less than initial value					
	tanδ	3.3 to 33μF : Less than initial limit 47 to 220μF : Less than 150% of initial limit TCFGB0G227 : Less than 200% of initial limit	-				
Loading at High temperature	Appearance	There should be no significant abnormality. The indications should be clear.	As per 4.23 JIS C 5101-1 As per 4.15 JIS C 5101-3				
	L.C	TCFGB0G227 : Less than 150% of initial limit TCFGB1E475 : Less than 150% of initial limit TCFGB0E227 : Less than 125% of initial limit Others : Less than initial limit	After applying the rated voltage for 2000+72/0h without discontinuation via the serial resistance of 3Ω or less at a temperature of 85±2°C, leave the sample at room temperature/humidity for 1 to 2h and measure the value				
	ΔC / C	TCFGB0G227 : Within ±15% Others : Within ±10%	After the specimens, leave it at room temperatu for over 24h and then measure the sample.				
	tanδ	3.3 to 33µF : Less than initial limit 47 to 220µF : Less than 150% of initial limit TCFGB0G227 : Less than 200% of initial limit TCFGB1C336 : Less than 150% of initial limit					
Terminal	Capacitance	The measured value should be stable.	As per 4.35 JIS C 5101-1				
Strength	Appearance	There should be no significant abnormality.	As per 4.9 JIS C 5101-3 A force is applied to the terminal until it bends to 1mm and by a prescribed tool maintain the condition for 5s. (See the figure below.) $50 \xrightarrow{20}$ F (Apply force) (Unit : mm) F (Apply force) Thickness 1.6mm 1				
Adhesivene	ess	The terminal should not come off.	As per 4.34 JIS C 5101-1				
			As per 4.8 JIS C 5101-3 Apply force of 5N in the two directions shown in the figure below for 10±1s after mounting the terminal on a circuit board.				



TCFG Series B Case

Tantalum capacitors

Item		Performance	Test conditions (based on JIS C5101-1 and JIS C5101-3)			
Dimensions		Be based on "External dimensions"	Measure using a caliper of JIS B 7505 Class 2 or higher grade.			
Resistance to solvents		The indication should be clear.	As per 4.32 JIS C 5101-1 As per 4.18 JIS C 5101-3 Dip in the isopropyl alcohol for 30±5s, at room temperature.			
Solderability		3/4 or more surface area of the solder coated terminal dipped in the soldering bath should be covered with the new solder.	As per 4.15.2 JIS C 5101-1 As per 4.7 JIS C 5101-3 Dip speed = 25±2.5mm/s Pre-treatment (accelerated aging) : Leave the sample on the boiling distilled water for 1h. Solder temp. : 245±5°C Duration : 3±0.5s Solder : M705 Flux : Rosin 25%, IPA 75%			
Vibration	Capacitance Appearance	Measure value should not fluctuate during the measurement. There should be no significant abnormality.	As per 4.17 JIS C 5101-1 Frequency : 10 to 55 to 10Hz/min. Amplitude : 1.5mm Time : 2h each in X and Y directions Mounting : The terminal is soldered on a print circuit board.			



•Standard list, TCFG series B Cases

										(B :	: 3528)
Part No.	Rated Voltage	Derated Voltage	Surge Voltage	Capacitance	Tolerance	Leakage current 25°C	DF 120Hz (%)			Impedance 100kHz	Case
	(V)	(V)	(V)	(μF)	(%)	1WV.60s (μA)	-55°C	25°C 85°C	125°C	(Ω)	code
TCFG B 0E 227□	2.5	1.6	3.2	220	±20,10	5.5	34	18	22	1.5	В
TCFG B 0G 156 🗆	4	2.5	5	15	±20,10	0.6	12	8	10	3.0	В
TCFG B 0G 226 □	4	2.5	5	22	±20,10	0.9	12	8	10	3.0	В
TCFG B 0G 336 🗆	4	2.5	5	33	±20,10	1.3	12	8	10	2.5	В
TCFG B 0G 476 🗆	4	2.5	5	47	±20,10	1.9	14	10	12	2.0	В
TCFG B 0G 686 □	4	2.5	5	68	±20,10	2.7	14	10	12	1.9	В
TCFG B 0G 107 🗆	4	2.5	5	100	±20,10	4.0	30	12	16	1.6	В
TCFG B 0G 157 🗆	4	2.5	5	150	±20,10	6.3	34	18	22	1.3	В
TCFG B 0G 227 🗆	4	2.5	5	220	±20,10	8.8	40	20	30	1.3	В
TCFG B 0J 106 🗆	6.3	4	8	10	±20,10	0.6	12	8	10	3.0	В
TCFG B 0J 156 🗆	6.3	4	8	15	±20,10	0.9	12	8	10	3.0	В
TCFG B 0J 226 🗆	6.3	4	8	22	±20,10	1.4	12	8	10	2.5	В
TCFG B 0J 336 🗆	6.3	4	8	33	±20,10	2.1	12	8	10	2.0	В
TCFG B 0J 476 🗆	6.3	4	8	47	±20,10	3.0	14	10	12	1.9	В
TCFG B 0J 686 🗆	6.3	4	8	68	±20,10	4.3	30	12	16	1.6	В
TCFG B 0J 107 🗆	6.3	4	8	100	±20,10	6.3	30	12	16	1.5	В
TCFG B 0J 157 🗆	6.3	4	8	150	±20,10	9.5	34	18	22	1.5	В
TCFG B 0J 227 🗆	6.3	4	8	220	±20,10	70	60	30	45	1.3	В
TCFG B 1A 475 🗆	10	6.3	13	4.7	±20,10	0.5	10	6	8	3.0	В
TCFG B 1A 685 🗆	10	6.3	13	6.8	±20,10	0.7	12	8	10	3.0	В
TCFG B 1A 106 🗆	10	6.3	13	10	±20,10	1.0	12	8	10	3.0	В
TCFG B 1A 156 🗆	10	6.3	13	15	±20,10	1.5	12	8	10	2.5	В
TCFG B 1A 226 🗆	10	6.3	13	22	±20,10	2.2	12	8	10	2.0	В
TCFG B 1A 336 🗆	10	6.3	13	33	±20,10	3.3	14	10	12	1.9	В
TCFG B 1A 476 🗆	10	6.3	13	47	±20,10	4.7	14	10	12	1.6	В
TCFG B 1C 335 🗆	16	10	20	3.3	±20,10	0.5	10	6	8	4.2	В
TCFG B 1C 475 🗆	16	10	20	4.7	±20,10	0.8	10	6	8	3.0	В
TCFG B 1C 685 🗆	16	10	20	6.8	±20,10	1.1	10	6	8	3.0	В
TCFG B 1C 106 🗆	16	10	20	10	±20,10	1.6	10	6	8	2.5	В
TCFG B 1C 156 🗆	16	10	20	15	±20,10	2.4	10	6	8	2.0	В
TCFG B 1C 226 🗆	16	10	20	22	±20,10	3.5	10	6	8	1.9	В
TCFG B 1D 335 🗆	20	13	26	3.3	±20,10	0.66	10	6	8	4.2	В
TCFG B 1E 335 🗆	25	16	32	3.3	±20,10	0.83	10	6	8	4.2	В
TCFG B 1E 475 🗆	25	16	32	4.7	±20,10	1.2	10	6	8	3.0	В

□ =Tolerance (M : ±20%, K : ±10%)

rohm

TCFG Series B Case

Tantalum capacitors

Packaging specifications

Case code	A±0.1	B±0.1	t1±0.05	t2±0.1
B (3528)	3.3	3.8	0.25	2.2



Packaging style

Case code	Packaging	Packag	ing style	Symbol	Basic ordering unit
B Case	Taping	Plastic taping	¢180mm reel	R	2,000

rohm



Recommended condition of reflow soldering



(2) Derating voltage as function of temperature



(3) Reliability

The malfunction rate of tantalum solid state electrolytic capacitors varies considerably depending on the conditions of usage (ambient temperature, applied voltage, circuit resistance).

Formula for calculating malfunction rate

 $\lambda p = \lambda b \times (\pi E \times \pi SR \times \pi Q \times \pi CV)$

- λp : Malfunction rate stemming from operation
- $\lambda b \quad : \text{Basic malfunction rate} \quad$
- π_{E} : Environmental factors
- πSR : Series resistance
- π_Q : Level of malfunction rate
- πcv : Capacitance

For details on how to calculate the malfunction rate stemming from operation, see the tantalum solid state electrolytic capacitors column in MIL-HDBK-217.

Malfunction rate as function of operating temperature and rated voltage



(4) External temperature vs. fuse blowout



Note: Solder the chip at 300°C or less. If it is soldered using a temperature higher than 300°C, open function built-in may operate.

TCFG Series B Case

Malfunction rate as function of circuit resistance (Ω /V)



(5) Power vs. fuse blowout characteristics / Product surface temperature



(6) Maximum power dissipation

Warming of the capacitor due to ripple voltage balances with warming caused by Joule heating and by radiated heat. Maximum allowable warming of the capacitor is to 5°C above ambient temperature. When warming exceeds 5°C, it can damage the dielectric and cause a short circuit.

Power dissipation (P) = $I^2 \cdot R$

Ripple current

P: As shown in table at right

R : Equivalent series resistance

Notes:

1. Please be aware that when case size is changed, maximum allowable power dissipation is reduced.

2. Maximum power dissipation varies depending on the package. Be sure to use a case which will keep warming within the limits shown in the table below.

· ·	· ·	,		
Ambient temp. Case	+25°C	+55°C	+85°C	+125°C
B case (3528)	0.080	0.072	0.064	0.032
Max. Temp Rise[°C]	5	5	5	2

Allowable power dissipation (W) and maximum temperature rising

(7) Impedance frequency characteristics





(9) Temperature characteristics



(8) ESR frequency characteristics







Fig.10



Inrush current

Beware of inrush current. Inrush currents are inversely proportional ESR. Large inrush currents can cause components failure.



Inrush current can be limited by means of a protective resistor.



Fig. 14 Imax change due to protective resistor R

(10) Ultrasonic cleaning

Carry out cleaning under as mild conditions as possible. The internal element of a tantalum capacitor are larger than those of a transistor or diode, so it is not as resistant as ultrasonic waves.

Example : water

Propagation speed 1 Solvent density 1

1500m/s 1g/cm³

Frequency and wavelength

FrequencyWavelength20kHz7.5cm28kHz5.3cm50kHz3.0cm

Precautions

- 1) Do not allow solvent to come to a boil (kinetic energy increases).
- . Ultrasonic output 0.5W / cm² or less
- . Use a solvent with a high boiling point.
- . Lower solvent temperature.
- 2) Ultrasonic cleaning frequency 28 kHz or less
- 3) Keep cleaning time as short as possible.
- 4) Move item being cleaned.

Standing waves caused by the ultrasonic waves can cause stress to build up in part of the item being cleaned.

Reference

 $\label{eq:Kinetic energy} \text{Kin etic energy} = 2 \times \pi \times \text{frequency} \times \sqrt{\frac{2 \times \text{Ultrasonic output}}{\text{propagation} \times \text{speed} \times \text{solvent density}}}$



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Appendix1-Rev2.0